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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/755,207	CHEN ET AL.	
Examiner	Art Unit	

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Tu X. Nguyen

SEARCHED				
Class	Subclass Date		Examiner	
455	437	4/11/2007	TN	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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